

**Notice of References Cited**

Application/Control No.

10/586,706

Applicant(s)/Patent Under  
Reexamination  
KOIKE ET AL.

Examiner

DUC M. NGUYEN

Art Unit

2618

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,909,643	06-1999	Aihara, Yuukichi	455/127.3
*	B	US-6,055,422	04-2000	Saitoh, Tetsuya	455/277.1
*	C	US-4,368,355	01-1983	Ichikawa, Toshihito	381/15
*	D	US-4,035,585	07-1977	Ogita, Minoru	381/8
*	E	US-4,680,792	07-1987	Tanaka et al.	381/12
*	F	US-4,716,589	12-1987	Matsui, Toshiya	381/3
*	G	US-3,825,697	07-1974	Cornell et al.	381/4
*	H	US-5,408,685	04-1995	Kennedy et al.	455/65
*	I	US-5,343,534	08-1994	Dorrough et al.	381/123
*	J	US-4,224,471	09-1980	Ogita, Minoru	381/7
*	K	US-4,504,966	03-1985	Hershberger, David L.	381/15
*	L	US-5,377,272	12-1994	Albean, David L.	381/13
*	M	US-4,302,626	11-1981	Streeter, Robert D.	381/15

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2001-359196	12-2001	Japan	Hashimoto et al	H04R 3/00
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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